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# Software Testing & Debugging

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# Test Requirement, Coverage Criteria, and Coverage

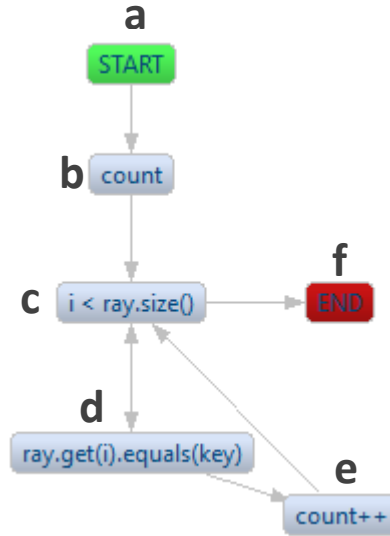
- ▶ **Test Requirement (TR):** a specific element of software artifact that a test case must satisfy/cover.
  - ❖ Software artifact can be source code, user manual, API doc, design components (e.g., UML diagrams), GUI, input space, etc.
- ▶ **Coverage Criterion:** a rule or collection of rules to generate test requirements from a software artifact.
- ▶ **Coverage:** Given the set of TRs for a coverage criterion  $C$ , a test set  $T$  satisfies  $C$  (i.e., achieves coverage  $C$ ) if and only if for any test requirement  $tr$  in  $TR$ , there is a test case  $t$  in  $T$  that covers/satisfies  $tr$ .

# Example: Path Coverage Criterion

```
public static int countOf(ArrayList<Integer> ray, int key) {  
    int count = 0;  
    for (int i = 0; i < ray.size(); ++i) {  
        if (ray.get(i).equals(key)) {  
            count++;  
        }  
    }  
    return count;  
}
```

// Tests

```
List ray0 = new ArrayList<Integer>();  
List ray1 = new ArrayList<Integer>();  
ray1.add(2);  
countOf(ray0, 2); // abcf  
countOf(ray1, 1); // abcdcf  
countOf(ray1, 2); // abcdecf
```



**Paths to cover:**

*abcf*  
*abcdcf*  
*abcdecf*

Test requirements

# More Definitions

- ▶ **Minimal Test Set:** Given a set of test requirements  $TR$  and a test set  $T$ ,  $T$  is minimal if removing any single test case from  $T$  will cause  $T$  to no longer satisfy all test requirements in  $TR$ .
- ▶ **Minimum Test Set:** A test set  $T$  that satisfies all test requirements in  $TR$  is minimum if there exists no smaller test set that can also satisfy all test requirements in  $TR$ .
- ▶ **Coverage Level:** Given test set  $T$  and test requirements set  $TR$ , assume that  $T$  covers/satisfies  $x$  number of test requirements in  $TR$ . The coverage level of  $T$  is:  $\frac{x}{|TR|}$

# Test Requirement Infeasibility

- ▶ Some test requirements may be infeasible, i.e., can never be satisfied.
- ▶ **Example:** unreachable code, thus not possible to achieve statement or branch coverage → infeasible test requirement

```
if (x < 0) {  
    // do some stuff  
}  
else if (x < -2) {  
    // do some other stuff  
}
```

# Ways to Leverage Coverage Criteria

- ▶ 1: directly derive test cases to achieve coverage
  - ❖ Systematic
  - ❖ Not always easy/straightforward/possible
  - ❖ May not be always possible to automate
- ▶ 2: derive test cases and measure coverage level
  - ❖ Less systematic
  - ❖ Easier/more straightforward to perform
  - ❖ (The more) common practice in the industry

# How to Utilize Coverage Criteria?

- ▶ 1: directly derive test cases to achieve coverage



**Generator, i.e., “Test Generation” tools**

- ▶ 2: derive test cases and measure coverage level:



**Recognizer, i.e., “Coverage Analysis” tools**

# Important Question

Given a coverage criterion  $C$ , how do you compare 90% coverage level to 100% coverage level ? Does this mean the former is 10% less effective in revealing faults?



# Subsumption

How to compare different coverage criteria against each other?

How to decide if one coverage criterion is stronger/weaker than another one?



**Subsumption:** A test criterion C1 subsumes C2 if and only if every set of test cases that satisfies criterion C1 also satisfies C2

**Example:** Branch Coverage (BC) subsumes Statement Coverage (SC)

# Question

*Assume coverage criterion  $C1$  subsumes coverage criteria  $C2$ .  $T1$  is a test set that satisfies  $C1$  on program  $P$  and  $T2$  is another test set that satisfies  $C2$  on  $P$ . It can be concluded that  $T1$  detects at least as many faults in  $P$  as  $T2$  does.*

**True or False? Justify your answer.**

# Advantages of Criteria-based Testing

- ▶ Maximize the “bang for the buck”
  - ❖ Fewer tests that are more effective at finding faults
- ▶ Comprehensive test set with minimal overlap
- ▶ “Traceability” from software artifacts to tests
- ▶ A “stopping rule” for testing
- ▶ Lend themselves well to “automation”

# Question

**Any downsides to (or concerns with!) *criteria-based testing*?**

# Limitations of Coverage Criteria

- ▶ Might not be easy/straightforward to generate all the test requirements
- ▶ Might not be easy/straightforward to generate test cases that satisfy the generated test requirements
- ▶ Might still be very costly to achieve
- ▶ **Most important:** *what is the correlation, if any, between a coverage criterion satisfaction and its fault detection ability?*

# Question

Suppose that coverage criterion C1 subsumes coverage criterion C2. Further suppose that test set T1 satisfies C1 and on program P test set T2 satisfies C2, also on P.

1. Does T1 necessarily satisfy C2? Explain.
2. Does T2 necessarily satisfy C1? Explain.
3. If P contains a fault, and T2 reveals the fault, T1 does not necessarily also reveal the fault. Explain

# Combinatorial Coverage Criteria

- ▶ We already discussed equivalence partitioning (EP) technique when we talked about Blackbox testing
- ▶ We learned how to do EP on a domain
  - ❖ e.g., domain is integer values → negative, zero, positive
- ▶ In practice though, oftentimes we have several input/output domain to work with
  - ❖ e.g., a function that has more than one input parameter

**\*We need to work with combinations of equivalence blocks\***

# Example

```
/**
 * Count the number of occurrences of a target value in an ArrayList
 * @param ray the ArrayList instance
 * @param key the target value
 * @return count of occurrences
 */
public static int countOf(ArrayList<Integer> ray, int key) {
    int count = 0;
    for (int i = 0; i < ray.size(); ++i) {
        if (ray.get(i).equals(key)) {
            count++;
        }
    }
    return count;
}
```



# All Combinations Coverage

All Combinations (ACoC) : All combinations of blocks from all characteristics must be used.

**countOf example with the following blocks:**

- |                       |                 |
|-----------------------|-----------------|
| A. ArrayList null     | 1. key negative |
| B. ArrayList empty    | 2. key zero     |
| C. ArrayList size 1   | 3. key positive |
| D. ArrayList size > 1 |                 |

**Test requirements for ACoC would include all possible combinations of the blocks:**

**(A, 1), (A, 2), ..., (B, 1), ..., (D, 3)**

# Each Choice Coverage

Each Choice Coverage (ECC) : One value from each block for each characteristic must be used in at least one test case.

**countOf example with the following blocks:**

- |                       |                 |
|-----------------------|-----------------|
| A. ArrayList null     | 1. key negative |
| B. ArrayList empty    | 2. key zero     |
| C. ArrayList size 1   | 3. key positive |
| D. ArrayList size > 1 |                 |

**Test requirements for ECC would be:**

**(A, 1), (B, 2), (C, 3), (D, 1)**

# Pair-Wise Coverage

Pair-Wise Coverage (PWC) : A value from each block for each characteristic must be combined with a value from every block for each of the other characteristics.

**Assume we have three partitions with the following blocks:**

[A, B], [1, 2, 3], and [x, y]

**Test requirements for PWC would be:**

|           |           |
|-----------|-----------|
| (A, 1, x) | (B, 1, y) |
| (A, 2, x) | (B, 2, y) |
| (A, 3, x) | (B, 3, y) |
| (A, 1, y) | (B, 1, x) |

# t-Wise Coverage

t-Wise Coverage (TWC) : A value from each block for each group of  $t$  characteristics must be combined.

**Assume we have three partitions with the following blocks:**

$[A, B]$ ,  $[1, 2, 3]$ , and  $[x, y]$

**Test values for 3-wise coverage would be the same as ACoC, why?**

# Base Choice Coverage

Base Choice Coverage (BCC) : A base choice block is chosen for each characteristic, and a base test is formed by using the base choice for each characteristic. Subsequent tests are chosen by holding all but one base choice constant and using each non-base choice in each of the other characteristics.

Assume we have three partitions with the following blocks where A, 1, and x are base choices:

[A, B], [1, 2, 3], and [x, y]

Test values for BCC coverage would be:

(A, 1, x)                      base test

(B, 1, x) ←

(A, 2, x)

(A, 3, x)

(A, 1, y)

# Base Choice Selection

- ▶ “base choice” essentially corresponds to the “default” choice for a block
- ▶ Base choice should be feasible (i.e., executable)
- ▶ Base choices usually take the “happy path”
  - ❖ E.g., base choice block for “factor” is positive values

```
void multiples(int factor) {  
    if (factor <= 0) {  
        System.out.println("Provide a positive value!");  
    } else {  
        // Display consecutive positive factors until 100  
        int value = factor;  
        while (value <= 100) {  
            System.out.print(value + " ");  
            value = value + factor;  
        }  
    }  
}
```

# Relevant Reads & Resources

- ▶ Recommended Textbooks:

- ❖ Introduction to Software Testing, 2<sup>nd</sup> Edition: ch5 and ch6



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